

Uncertainty Quantification and Propagation in Multiphysics Modeling of the PVT Growth of the SiC Crystal

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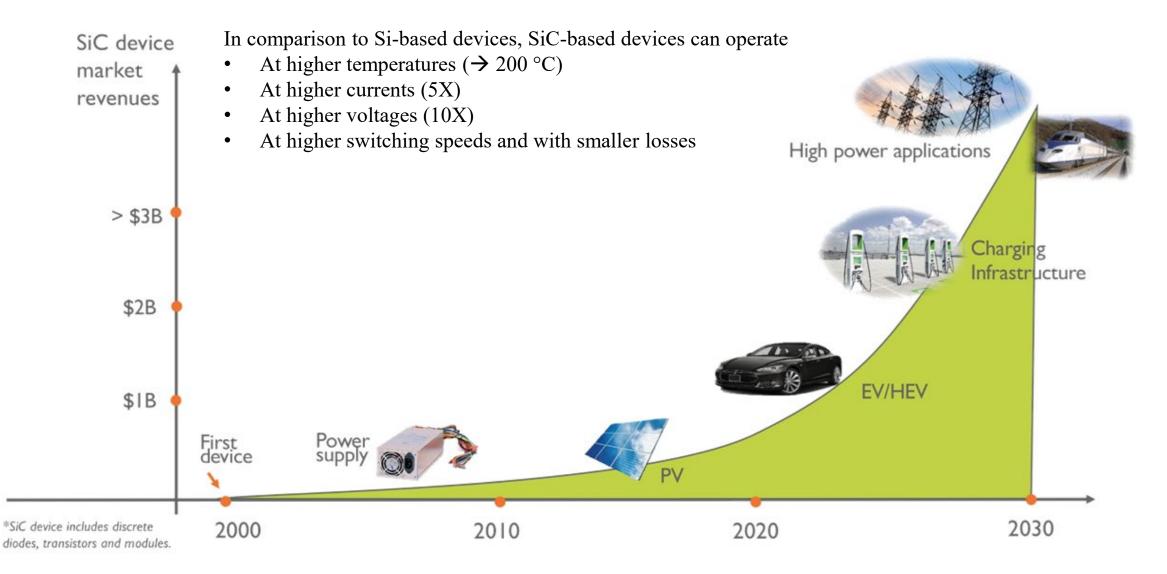
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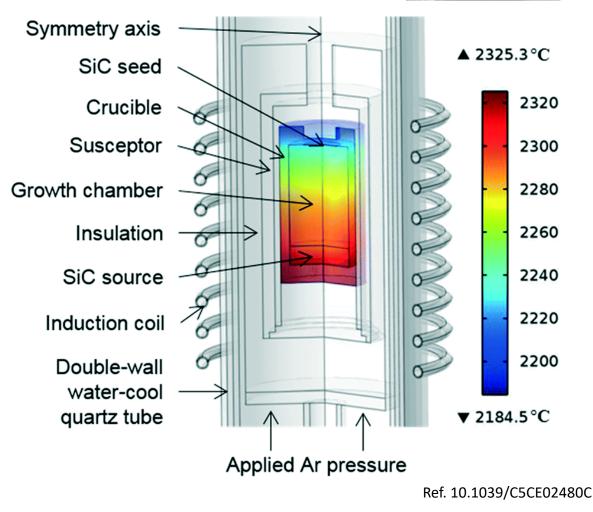
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SiC in power electronics



Physical vapor transport (PVT)

- SiC single crystal growth via PVT involves inductive heating of the SiC source material to 2300 °C, causing SiC sublimation to various vapor species.
- These gas molecules condense on the cooler side, initiating crystal growth.
- Observing it externally is challenging.
- Simulation provides essential insights, including temperature distribution, mass transfer, gas composition, boule stresses, and crystal defects.





Motivation

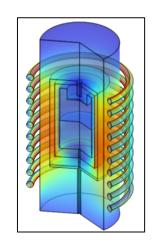
- Temperature Control Significance :
- Precise temperature control at the seed surface is fundamental for growing highquality SiC crystals.
- Temperature directly influences crystal quality, defect formation, and overall process efficiency.
- Uncertainty in Temperature Prediction:
- Predicting temperature at the seed surface involves complex thermo-physical properties and models.
- Uncertainties in these properties and models can introduce variations in temperature forecasts.

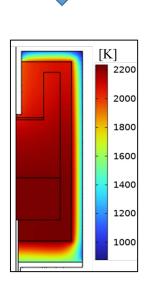
To account for the uncertainty in the thermo-physical material properties and various input parameters, a comprehensive uncertainty quantification and propagation analysis is needed.

Method

COMSOL multiphysics 6.1

- □ Electromagnetic heating
- ✓ AC/DC model
- □ Heat transfer
- \checkmark Heat transfer in solids
- ✓ Surface to surface radiation : Ray shooting model
- □ Uncertainty quantification
- ✓ Screening
- ✓ Sensitivity analysis
- ✓ Uncertainty propagation



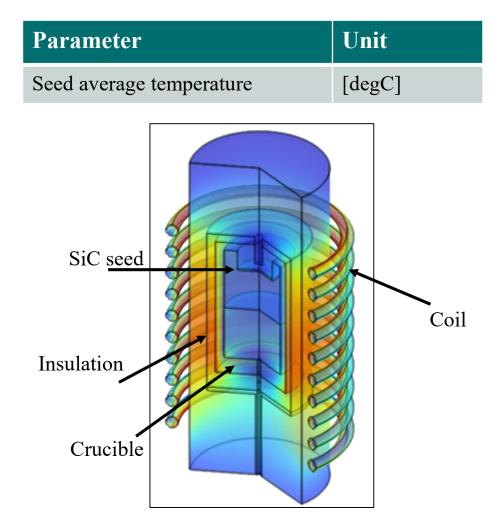


Input parameters

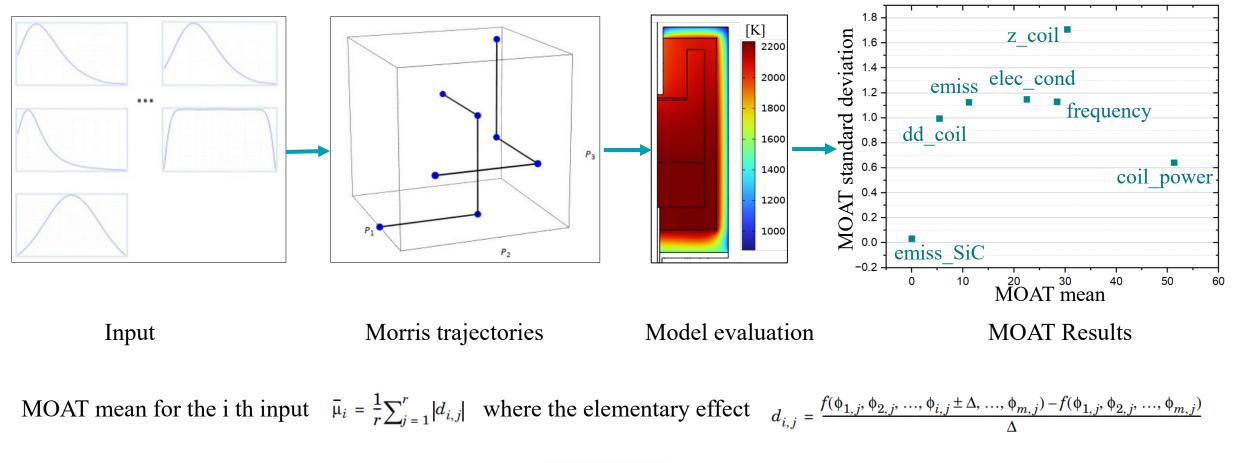
Parameter	Parameter range	Unit
Frequency	[6500-7500]	[Hz]
Coil power	[12.5-13.5]	[kW]
Electrical conductivity of insulation	[800-1200]	[S/m]
Coil position (r- direction)	[0.211-0.216]	[m]
Coil position (z-direction)	[0.005-0.015]	[m]
Emissivity of graphite (crucible)	[0.7-0.9]	[-]
Emissivity of SiC	[0.85-0.95]	[-]

Number of Input parameter: (m + 1)rwhere r is the repetition number and m the number of input parameters.

Quantity of interest (QoI)

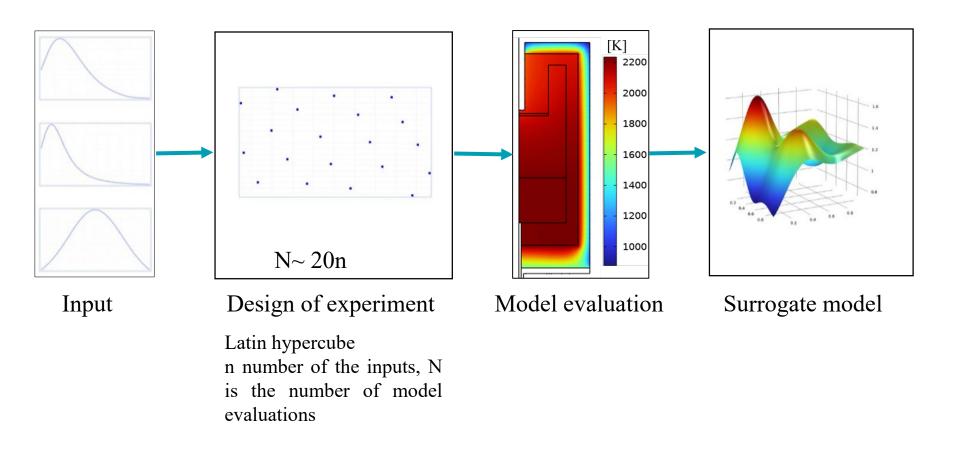


Screening, MOAT (Morris one-at-a-time method)

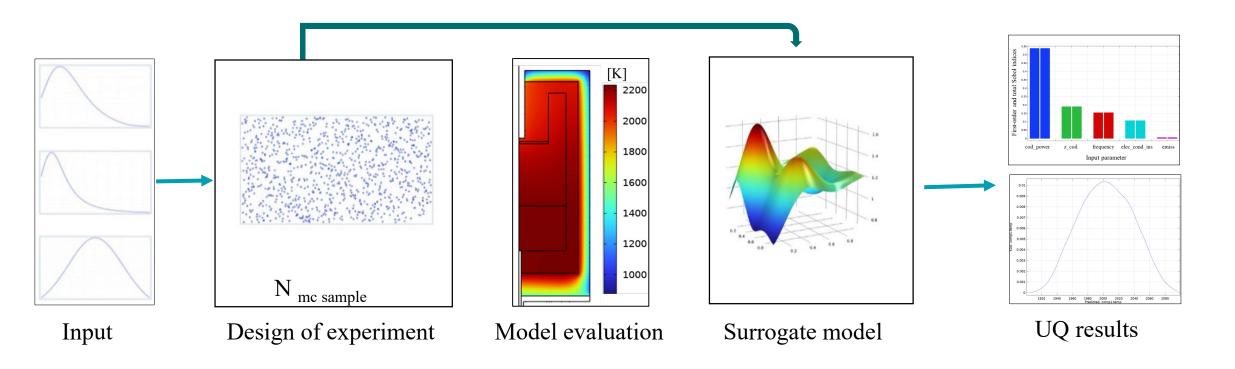


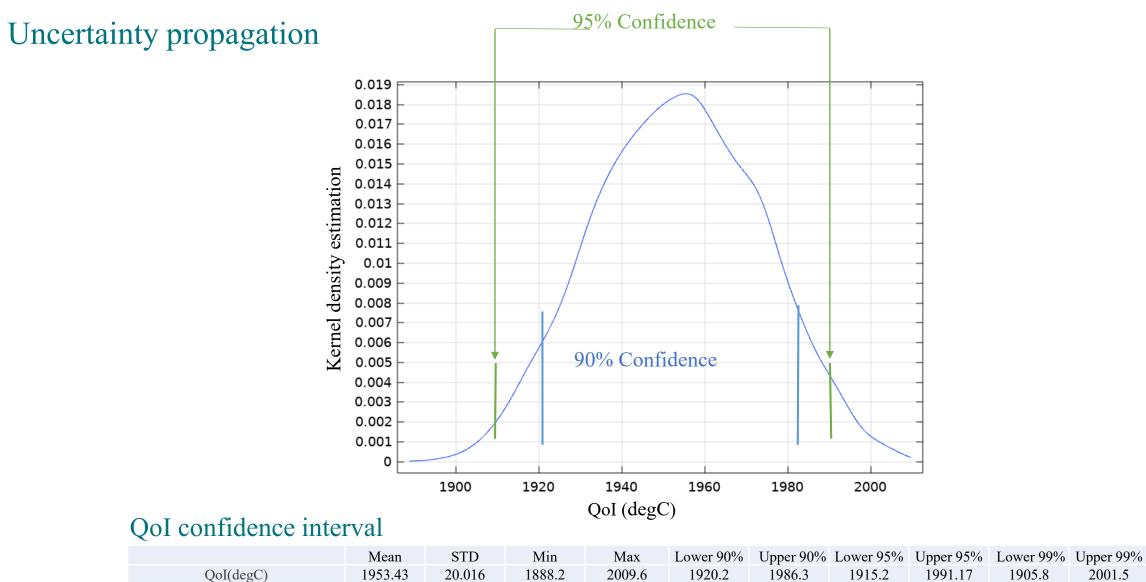
MOAT standard deviation for the i th input $\sigma_i = \sqrt{\frac{1}{r}\sum_{j=1}^r (d_{i,j} - \mu_i)^2}$,

Sensitivity analysis and uncertainty propagation



Sensitivity analysis and uncertainty propagation

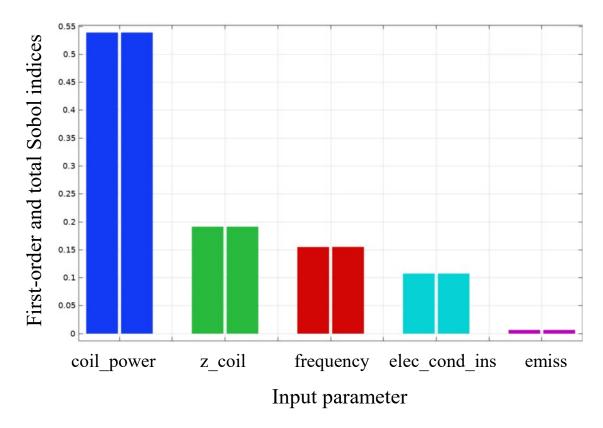




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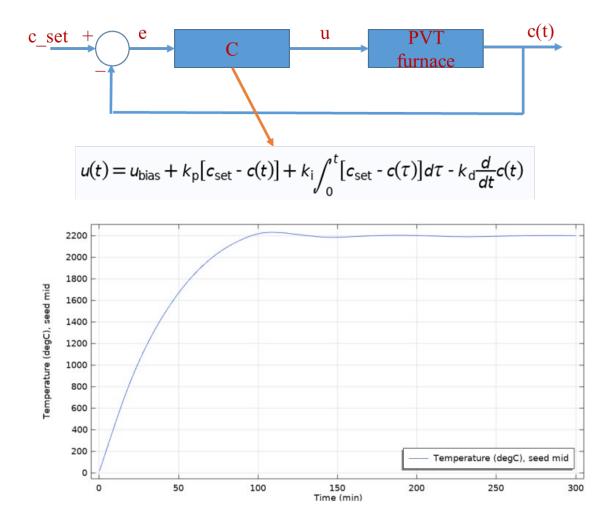
Sensitivity analysis

- Sobol indices (variance decomposition method, analysis of variance (ANOVA)).
- The primary goal of Sobol indices is to quantify and rank the sensitivity of a QoI to input parameters.
- Sobol indices break down the variance of the model's output into contributions from individual parameters and their interactions.



Controlling temperature in the furnace

Proportional-Integral-Derivative (PID)



Conclusion

- Numerical modeling provide a further understanding of the physicochemical behaviors of the crystal growth system and accelerate process optimization for SiC bulk crystal growth.
- Due to the uncertainty of the thermo-physical material properties and various input parameters, a thorough uncertainty quantification and propagation analysis is conducted.
- Uncertainty quantification highlights that power, frequency, and the position of the coils along the z-axis significantly impact the temperature of the seed surface.



Thank you for your attention!

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Acknowledgements

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